

## HAC RF EMISSIONS TEST REPORT

## FCC 47 CFR § 20.19 ANSI C63.19-2011

For

GSM/WCDMA/LTE/5G NR Phone + BT/BLE, DTS/UNII a/b/g/n/ac and NFC

**MODEL NUMBER: SM-A236V** 

FCC ID: A3LSMA236V

REPORT NUMBER: 4790558569-S3V3

**ISSUE DATE: 11/28/2022** 

Prepared for

SAMSUNG ELECTRONICS CO., LTD. 129 SAMSUNG-RO, YEONGTONG-GU, SUWON-SI, GYEONGGI-DO, 16677, KOREA

Prepared by

UL Korea, Ltd.

26th floor, 152, Teheran-ro, Gangnam-gu Seoul, 06236, Korea

Suwon Test Site: UL Korea, Ltd. Suwon Laboratory 218 Maeyeong-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16675, Korea

TEL: (031) 337-9902 FAX: (031) 213-5433



**Testing Laboratory** 

TL-637

## **Revision History**

Rev.	Date	Revisions	Revised By
V1	11/10/2022	Initial Issue	-
V2	11/18/2022	Revised items - Added Antenna input power for UL CA in Sec.7 - Corrected table in Sec.8.1	Eunji Choi
V3	11/28/2022	Revised items - Added Google Meet application in Sec.8.1	Eunji Choi

# **Table of Contents**

1.	Att	testation of Test Results	4
2.	Tes	st Methodology	5
3.	Fac	cilities and Accreditation	5
4.	Cal	libration and Uncertainty	5
2	4.1.	Measuring Instrument Calibration	5
2	<i>4.2.</i>	Measurement Uncertainty	6
2	4.3.	DECISION RULE	6
5.	Sys	stem Specifications	7
6.	Sys	stem Validation	8
6	6.1.	System Validation Results	9
7.	Ave	verage Antenna Input Power & Evaluation for Low-power Exemption	10
8.	De	evice Under Test	11
8	3.1.	Air Interfaces and Operating Mode	11
9.	Мо	odulation Interference Factor (MIF)	12
10.	HA	AC RF Emissions Test Procedure	14
11.	RF	Emissions Measurement Criteria	17
12.	. HA	AC (RF Emissions) Test Results	17
		. Worst Case RF Emission Test Plot	
Аp	pend	dixes	19
•	-	0136529-S2 Appendix A: Setup Photo	
2	<b>479</b> 0	0136529-S2 Appendix B: System Validation Plots	19
4	<b>479</b> 0	0136529-S2 Appendix C: Test Plots	19
		0136529-S2 Appendix D: MIF Attestation Letter	
2	<b>479</b> 0	0136529-S2 Appendix E: Probe Certificates	19
2	<b>479</b> 0	0136529-S2 Appendix F: Dipole Certificates	19
_	<b>179</b> 0	0136529-S2 Appendix G: UID Specifications	19

## 1. Attestation of Test Results

Applicant Name	SAMSUNG ELECTRONICS CO., LTD.
FCC ID	A3LSMA236V
Model Name	SM-A236V
Applicable Standards	FCC 47 CFR § 20.19 ANSI C63.19-2011
HAC Rating	M3
Date Tested	11/10/2022
Test Results	Pass

UL Korea, Ltd. tested the above equipment in accordance with the requirements set forth in the above standards. All indications of Pass/Fail in this report are opinions expressed by UL Korea, Ltd. based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report..

**Note:** The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. This document may not be altered or revised in any way unless done so by UL Korea, Ltd. and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL Korea, Ltd. will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by IAS, any agency of the Federal Government, or any agency of any government.

Approved & Released By:	Prepared By:
-flex	wer
Justin Park	Eunji Choi
Operations Leader	Laboratory Test Engineer
UL Korea, Ltd. Suwon Laboratory	UL Korea, Ltd. Suwon Laboratory

# 2. Test Methodology

The tests documented in this report were performed in accordance with ANSI C63.19-2011 Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids abd FCC Published procedure.

KDB 285076 D01 HAC Guidance v06r02 KDB 285076 D03 HAC FAQ v01r06 TCB workshop updates

### 3. Facilities and Accreditation

The test sites and measurement facilities used to collect data are located at

Suwon
SAR 2 Room (HAC)

UL Korea, Ltd. is accredited by IAS, Laboratory Code TL-637.

The full scope of accreditation can be viewed at <a href="https://www.iasonline.org/wp-content/uploads/2017/05/TL-637-cert-New.pdf">https://www.iasonline.org/wp-content/uploads/2017/05/TL-637-cert-New.pdf</a>.

# 4. Calibration and Uncertainty

## 4.1. Measuring Instrument Calibration

The measuring equipment utilized to perform the tests documented in this report has been calibrated in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
MXG Analog Signal Generator	Agilent	N5181A	MY50145882	8-4-2023
Pow er Sensor	Keysight	U2000A	MY60180020	8-3-2023
Pow er Sensor	Keysight	U2000A	MY54260007	8-3-2023
Pow er Amplifier	EXODUS	AMP2027ADB	10002	3-30-2023
Directional Coupler	Keysight	772D	MY52180193	8-3-2023
Directional Coupler	H.P	778D	16133	8-3-2023
Low Pass Filter	MICROLAB	LA-15N	3943	8-3-2023
Low Pass Filter	FILTRON	L14012FL	1410003S	8-3-2023
Attenuator	Keysight	8491B/010	MY39272011	8-2-2023
Attenuator	Keysight	8481B/020	MY39271973	8-3-2023
Attenuator	MINI-CIRCUITS	BW-S3W10+	N/A	4-7-2023
Data Acquisition Electronics (SAR2)	SPEAG	DA E4	1668	4-27-2023
E-Field Probe*	SPEAG	EF3DV3	4066	7-19-2023
Calibration Dipole	SPEAG	CD835V3	1000	9-27-2023
Calibration Dipole	SPEAG	CD1880V3	1000	9-27-2023
Calibration Dipole	SPEAG	CD3500V3	1011	8-24-2023
Wireless Radio Communication Tester	R&S	CMW 500	150314	8-2-2023
UXM 5G Wireless Test Platform	Keysight	E7515B	MY57510596	8-5-2023

#### Note(s):

<sup>\*:</sup> According to SPEAG's Technical Report, "MIF Verification", Doc # TR-FB-12.09.04-1, issued date: 9/4/2012. E-field probes are calibrated with specified uncertainty according to ISO 17025 as described in their calibration certificate. The MIF according to the definition in ANSI C63.19 is specific for a modulation and can therefore be used as a constant value if the probe has been PMR calibrated.

## 4.2. Measurement Uncertainty

Measurement Uncertainty for Radio Frequency Emissons Measurement

Error Description	Explanation	Uncertainty value (±%)	Probe Dist.	Divisor	(Ci) E	(Ci) H	Std. Unc.(±%)
Measurement System							
Probe Calibration	A.1	5.10	Normal	1	1	1	5.10
Axial Isotropy	A.2	4.70	Rectangular	1.732	1	1	2.71
Sensor Displacement	A.3	16.50	Rectangular	1.732	1	0.145	9.53
Boundary Effects	A.4	2.40	Rectangular	1.732	1	1	1.39
Phantom Boundary Effects	A.5	7.20	Rectangular	1.732	1	0	4.16
Linearity	A.6	4.70	Rectangular	1.732	1	1	2.71
Scaling to PMR Calibration	A.7	10.00	Rectangular	1.732	1	1	5.77
System Detection Limit	A.8	1.00	Rectangular	1.732	1	1	0.58
Readout Electronics	A.9	0.30	Normal	1	1	1	0.30
Response Time	A.10	0.80	Rectangular	1.732	1	1	0.46
Integration Time	A.11	2.60	Rectangular	1.732	1	1	1.50
RF Ambient Conditions	A.12	3.00	Rectangular	1.732	1	1	1.73
RF Reflections	A.13	12.00	Rectangular	1.732	1	1	6.93
Probe Positioner	A.14	1.20	Rectangular	1.732	1	0.67	0.69
Probe Positioning	A.15	4.70	Rectangular	1.732	1	0.67	2.71
Extrapolation and Interpolation	A.16	1.00	Rectangular	1.732	1	1	0.58
Test sample Related	•						•
Test Positioning Vertical	A.17	4.70	Rectangular	1.732	1	0.67	2.71
Test Positioning Lateral	A.18	1.00	Rectangular	1.732	1	1	0.58
Device Holder and Phantom	A.19	2.40	Rectangular	1.732	1	1	1.39
Pow er Drift	A.20	5.00	Rectangular	1.732	1	1	2.89
Phantom and Setup Related	•						•
Phantom Thickness	A.21	2.40	Rectangular	1.732	1	0.67	1.39
Combined Std. Uncertainty							16.31
Expanded Std. Uncertainty on Power (Coverage Factor for 95%, k = 2)					32.62		
Expanded Std. Uncertainty on Field						16.31	
Notes for table						•	

Notes for table

### 4.3. DECISION RULE

Decision rule for statement(s) of conformity is based on Procedure 1, Clause 4.4.2 in IEC Guide 115:2007.

<sup>1.</sup> Ci - is te sensitivity coefficient

<sup>2.</sup> Expanded Std. Uncertainty on Power, Coverage Factor = 2, > 95% Confidence

<sup>3.</sup> Expanded Std. Uncertainty on Field is half value of Expanded Std. Uncertainty on pow er

# 5. System Specifications

E-field measurements are performed using the DASY52 automated dosimetric assessment system. The DASY52 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland.

The DASY52 HAC Extension consists of the following parts:

#### **Test Arch Phantom**

The specially designed Test Arch allows high precision positioning of both the device and any of the validation dipoles.

### **EF3DV3 Isotropic E-Field Probe**

Construction: One dipole parallel, two dipoles normal to probe axis

Interleaved sensors

Built-in shielding against static charges

PEEK enclosure material

Calibration: In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%, k=2)

ISO/IEC 17025 calibration service available.

Frequency: 40 MHz - > 6 GHz (can be extended to < 20 MHz);

Linearity: ±0.2 dB (100 MHz – 3 GHz)

Directivity:  $\pm 0.2$  dB in air (rotation around probe axis)

± 0.4 dB in air (rotation normal to probe axis)

Dynamic Range: 2 V/m to > 1000 V/m; Linearity: ± 0.2 dB

Dimensions: Overall length: 337 mm (Tip: 20 mm)

Tip diameter: 3.9 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 1.5 mm

Sensor displacement to probe's calibration point: <0.7 mm

Application: General near-field measurements up to 6 GHz

HAC measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms

# 6. System Validation

The test setup was validated when first configured and verified periodically thereafter to ensure proper function. The procedure provided in this section is a validation procedure using dipole antennas for which the field levels were computed by numeric modeling.

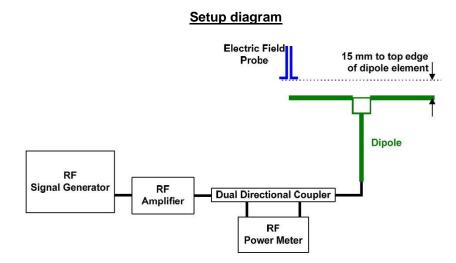
#### Procedure:

Place a dipole antenna meeting the requirements given in ANSI C63.19 in the normally occupied by the WD.

The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field probe so that the following occurs:

- The probes and their cables are parallel to the coaxial feed of the dipole antenna
- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions
- The center point of the probe element(s) is 15 mm from the closest surface of the dipole elements.

Scan the length of the dipole with the E-field probe and record the two maximum values found near the dipole ends. Average the two readings and compare the reading to the expected value in the calibration certificate or the expected value in this standard.



# 6.1. System Validation Results

			Dipole Cal.	Max. measured from		Average	Target (V/m)	Deviation	Plot
SAR Lab	Date	Dipole Type_Serial #_Freq.	Due Data	above high end (V/m)	above low end (V/m)	max. above arm (V/m)	(From SPEAG)	(note 1) ± %	No.
SAR 2	11-10-2022	CD835V3_SN:1000_(835MHz)	09-27-2023	118.20	117.80	118.00	107.90	9.36	1
SAR 2	11-10-2022	CD1880V3_SN:1000_(1880MHz)	09-27-2023	89.47	88.09	88.78	86.50	2.64	2
SAR 2	11-10-2022	CD3500V3_SN:1011_(3500MHz)	08-24-2023	86.90	86.30	86.60	82.40	5.10	3

#### Notes:

- 1) Delta (Deviation) % = 100 \* (Measured value minus Target value) divided by the Target value. Deltas within ±25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty.
- The maximum E-field or were evaluated and compared to the target values provided by SPEAG in the calibration certificate
  of specific dipoles.
- 3) Please refer to the appendix for detailed measurement data and plots.

# 7. Average Antenna Input Power & Evaluation for Low-power Exemption

An RF air interface technology of a device is exempt from testing when its average antenna input power plus its **MIF** is ≤17 dBm for any of its operating modes. If a device supports multiple RF air interfaces, each RF air interface shall be evaluated individually.

Air-Interface	Average Antenna Input Power (dBm) <sup>1</sup>	Worst Case MIF (dB)	Input Power plus its MIF (dBm)	HAC Tested
GSM850	33.5	3.63	37.13	Yes
GSM1900	30.7	3.63	34.33	Yes
W-CDMA Band II	24.5	-27.23	-2.73	No
W-CDMA Band V	25.2	-27.23	-2.03	No
LTE Band 2	25.0	-9.76	15.24	No
LTE Band 4	24.5	-9.76	14.74	No
LTE Band 5	25.5	-9.76	15.74	No
LTE Band 7	24.5	-9.76	14.74	No
LTE Band 12	25.5	-9.76	15.74	No
LTE Band 13	25.5	-9.76	15.74	No
LTE Band 66	24.5	-9.76	14.74	No
LTE Band 48	23.5	-1.44	22.06	Yes
LTE Band 48 UL CA 48C	23.5	-1.44	22.06	No <sup>3</sup>
NR Band n2	25.0	-12.08	12.92	No
NR Band n5	25.5	-12.08	13.42	No
NR Band n66	25.0	-12.08	12.92	No
NR Band n77(PC3)	25.0	-1.64	23.36	Yes
NR Band n77(PC2)	27.0	-1.64	25.36	Yes
802.11b Antenna	10.0	-2.02	7.98	No <sup>2</sup>
802.11g Antenna	10.0	-2.02	7.98	No <sup>2</sup>
802.11n Antenna	11.0	-2.02	8.98	No <sup>2</sup>
802.11a Antenna	11.0	-3.15	7.85	No <sup>2</sup>
802.11ac Antenna	11.0	-3.15	7.85	No <sup>2</sup>
Bluetooth Antenna	16.0	1.02	17.02	N/A

### Note(s):

- 1. Max tune-up limit.
- 2. WLAN are supported power reduction during voice call.
- LTE Band 48 supports intra-band contiguous uplink carrier aggregation(UL CA) with same target power of standalone(non-CA) mode. Testing for UL CA is not required because it uses same Tx band, modulations, and output power does not exceed standalone(non-CA) mode.

## 8. Device Under Test

Normal operation	Held to head	Held to head				
Back Cover	The Back Cover is not removable					
	S/N	Notes				
Test sample information	664a0eddd4347ece	RF Emission Test				

# 8.1. Air Interfaces and Operating Mode

Air Interface	Bands (MHz)	Туре	C63.19 Tested	Simultaneous Transmitter	OTT Testing Required? Name of Voice Service	Power Reduction
	850	VO	Yes	Wi-Fi and BT	CMRS	NA
GSM	1900	V	163	WI-I I Alla DI		
	GPRS/EDGE	VD	No	Wi-Fi and BT	Google Duo Google Meet <sup>3</sup>	No
	850 (V)	VO	No <sup>1</sup>	Wi-Fi and BT	CMRS	NA
W-CDMA	1900 (II)	V	INO	WI-FI AND DI	OWING	IVA
(UMTS)	HSPA	VD	No <sup>1</sup>	Wi-Fi and BT	Google Duo Google Meet <sup>3</sup>	NA
	700 (B12)					
	780 (B13)			NR, Wi-Fi and BT		NA
LTE - FDD	850 (B5)	VD	No <sup>1</sup>		VoLTE Google Duo Google Meet <sup>3</sup>	
LIL-I DD	1700 (B4/66)	VD				
	1900 (B2)					
	2500 (B7)					
LTE - TDD	3600 (B48)	VD	Yes	NR, Wi-Fi and BT	VoLTE Google Duo Google Meet <sup>3</sup>	NA
	850 (n5)		No <sup>1</sup>	LTE, Wi-Fi and BT	Google Duo <sup>2</sup> Google Meet <sup>2, 3</sup>	NA
NR - FDD	1700 (n66)	VD				
	1900 (n2)					
NR - TDD	3500 (n77 DoD)	VD	Yes	LTE MESSAGE	Google Duo <sup>2</sup>	NA
NK - IDD	3700 (n77)	ט	162	LTE, Wi-Fi and BT	Google Meet <sup>2, 3</sup>	
	2450	VD	Yes	WWAN	VoWi-Fi Google Duo Google Meet <sup>3</sup>	NA
Wi-Fi	5200 (U-NII-1)					
	5300 (U-NII-2A)	VD	N - 1	WWAN and BT	VoWi-Fi Google Duo	NA
	5500 (U-NII-2C)	עע	No <sup>1</sup>	vv vv Ain and Bi	Google Meet <sup>3</sup>	INA
	5800 (U-NII-3)					
ВТ	2450	DT	NA	WWAN and Wi-Fi 5GHz	NA	NA

Туре

VO: Legacy Cellular Voice Service

DT: Digital Transport only (no voice)

VD: IP Voice Service over Digital Transport

CMRS: Commercial Mobile Radio Service

BT: Bluetooth

Note:

1. Evaluated for MIF and low power exemption

<sup>2.</sup> NR supports EN-DC(NSA) mode only.

3. Google Duo application has been upgraded to Google Meet.

# 9. Modulation Interference Factor (MIF)

The HAC Standard ANSI C63.19 defines a new scaling using the Modulation Interference Factor (MIF) which replaces the need for the Articulation Weighting Factor (AWF) during the evaluation and is applicable to any modulation scheme.

The Modulation Interference factor (MIF, in dB) is added to the measured average E-field (in dBV/m) and converts it to the RF Audio Interference level (in dBV/m). This level considers the audible amplitude modulation components in the RF E-field. CW fields without amplitude modulation are assumed to not interfere with the hearing aid electronics. Modulations without time slots and low fluctuations at low frequencies have low MIF values, TDMA modulations with narrow transmission and repetition rates of few 100 Hz have high MIF values and give similar classifications as ANSI C63.19.

#### **Definitions**

E-field probes have a bandwidth <10 kHz and can therefore not evaluate the RF envelope in the full audio band. DASY52 is therefore using the "indirect" measurement method according to ANSI C63.19 which is the primary method. These near field probes read the averaged E-field measurement. Especially for the new high peak-to-average (PAR) signal types, the probes shall be linearized by probe modulation response (PMR) calibration in order to not overestimate the field reading.

The evaluation method or the MIF is defined in ANSI C63.19 section D.7. An RMS demodulated RF signal is fed to a spectral filter (similar to an A weighting filter) and forwarded to a temporal filter acting as a quasi-peak detector. The averaged output of these filtering is called to a 1 kHz 80% AM signal as reference. MIF measurement requires additional instrumentation and is not well suited for evaluation by the end user with reasonable uncertainty It may alternatively be determined through analysis and simulation, because it is constraint and characteristic for a communication signal. DASY52 uses well defined signals for PMR calibration. The MIF of these signals has been determined by simulation and is automatically applied.

MIF values were not tested by a probe or as specified in the standards but are based on analysis provided by SPEAG for all the air interfaces (GSM, WCDMA, LTE, and Wi-Fi). The data included in this report are for the worst case operating modes. The UIDs used are listed below:

UID	Communication System Name	MIF (dB)
10021-DAC	GSM-FDD (TDMA, GMSK)	3.63
10011-CAB	UMTS-FDD (WCDMA)	-27.23
10170-CAE	LTE-FDD (SC-FDMA, 1 RB, 20 MHz, 16QAM)	-9.76
10182-CAE	LTE-FDD (SC-FDMA, 1 RB, 15 MHz, 16QAM)	-9.76
10176-CAG	LTE-FDD (SC-FDMA, 1 RB, 10 MHz, 16QAM)	-9.76
10235-CAG	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, 16QAM)	-1.44
10173-CAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16QAM)	-1.44
10061-CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)	-2.02
10077-CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 54 Mbps)	0.12
10069-CAD	IEEE 802.11a/h WiFi 5 GHz (OFDM, 54 Mbps)	-3.15
10591-AAC	IEEE 802.11n (HT Mixed, 20MHz, MCS0, 90pc dc)	-5.57
10616-AAC	IEEE 802.11ac WiFi (40MHz, MCS0, 90pc dc)	-5.57
10607-AAC	IEEE 802.11ac WiFi (20MHz, MCS0, 90pc dc)	-5.60
10626-AAC	IEEE 802.11ac WiFi (80MHz, MCS0, 90pc dc)	-5.64
10929-AAC	5G NR (DFT-s-OFDM, 1 RB, 10 MHz, QPSK, 15 kHz)	-15.06
10930-AAC	5G NR (DFT-s-OFDM, 1 RB, 15 MHz, QPSK, 15 kHz)	-15.06
10931-AAC	5G NR (DFT-s-OFDM, 1 RB, 20 MHz, QPSK, 15 kHz)	-15.06
10934-AAC	5G NR (DFT-s-OFDM, 1 RB, 40 MHz, QPSK, 15 kHz)	-15.07
10903-AAB	5G NR (DFT-s-OFDM, 1 RB, 40 MHz, QPSK, 30 kHz)	-16.68
10973-AAB	5G NR (DFT-s-OFDM, 1 RB, 100 MHz, QPSK, 30 kHz)	-1.64

A PMR calibrated probe is linearized for the selected waveform over the full dynamic range within the uncertainty specified in its calibration certificate. E-field probes have a bandwidth <10 kHz and can therefore not evaluate the RF envelope in the full audio band. DASY52 is therefore using the \indirect" measurement method according to ANSI C63.19 which is the primary method. These near field probes read the averaged E-field measurement. Especially for the new high peak-to-average (PAR) signal types, the probes shall be linearized by PMR calibration in order to not overestimate the field reading.

The MIF measurement uncertainty is estimated as follows, for modulation frequencies from slotted waveforms with fundamental frequency and at least 2 harmonics within 10 kHz:

- 0.2 dB for MIF -7 to +5 dB.
- 0.5 dB for MIF -13 to +11 dB
- 1 dB for MIF > -20 dB

## 10. HAC RF Emissions Test Procedure

The following are step-by-step test procedures.

- a) Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- b) Position the WD in its intended test position.
- c) Set the WD to transmit a fixed and repeatable combination of signal power and modulation characteristic that is representative of the worst case (highest interference potential) encountered in normal use. Transiently occurring start-up, changeover, or termination conditions, or other operations likely to occur less than 1% of the time during normal operation, may be excluded from consideration.
- d) The center sub-grid shall be centered on the T-Coil mode perpendicular measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane, refer to illustrated in Figure 1. If the field alignment method is used, align the probe for maximum field reception.
- e) Record the reading at the output of the measurement system
- f) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- g) Identify the five contiguous sub-grids around the center sub-grid whose maximum reading is the lowest of all available choices. This eliminates the three sub-grids with the maximum readings. Thus, the six areas to be used to determine the WD's highest emissions are identified.
- h) Identify the maximum reading within the non-excluded sub-grids identified in step g).
- i) Convert the highest field reading within identified in step h) to RF audio interference level, in V/m, by taking the square root of the reading and then dividing it by the measurement system transfer function, established in 5.5.1.1 Convert this result to dB(V/m) by taking the base-10 logarithm and multiplying by 20.
  - Indirect measurement method
  - Replacing step i), the RF audio interference level in dB (V/m) is obtained by adding the MIF (in dB) to the maximum steady-state rms field-strength reading, in dB (V/m), from step h). Use this result to determine the category rating
- j) Compare this RF audio interference level with the categories in Clause 8 (ANSI C63.19) and record the resulting WD category rating
- k) For the T-Coil mode M-rating assessment, determine whether the chosen perpendicular measurement point is contained in an included sub-grid of the first scan. If so, then a second scan is not necessary. The first scan and resultant category rating may be used for the T-Coil mode M rating.
  - Otherwise, repeat step a) through step i), with the grid shifted so that it is centered on the perpendicular measurement point. Record the WD category rating.

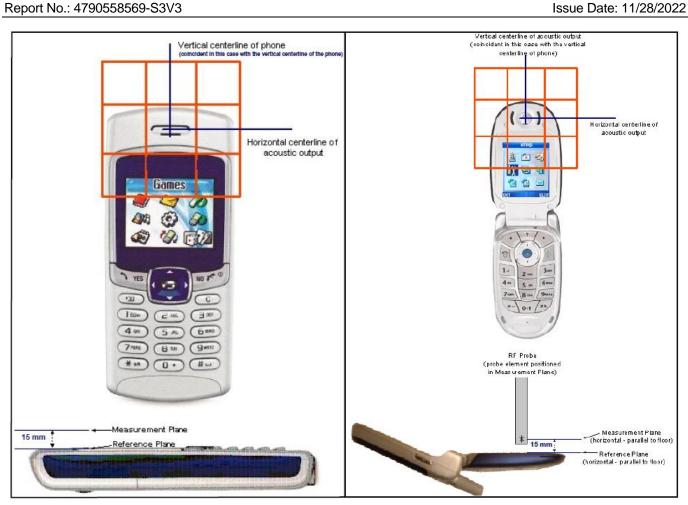


Figure 1 - WD reference and plane for RF emission measurements

### Test flowchart Per ANSI-63.19-2011

- Confirm proper operation of probes and instrumentation
- Position WD
- > Configure WD TX operation

Per 5.4.1.2 (1-3)

- Initialize field probe
- Scan Area

Per 5.4.1.2 (4-6)

- Identify exclusion area.
- Rescan or reanalyze open area to determine maximum
- Direct method: Record RF Audio Interference Level, in dB(V/m)
- Indirect method: Add the MIF to the maximum steady state rms field strength and record RF Audio Interference Level, in dB(V/m)

Per 5.4.1.2 (7-9) & 5.4.1.3

Identify and record the category

Per 5.4.1.2 (9-10)

## 11. RF Emissions Measurement Criteria

WD RF audio interference level caterories in logarithmic units

Emission Categories	E-field emissions			
	< 960 MHz	> 960 MHz		
Category M1	50 to 55 dB (V/m)	40 to 45 dB (V/m)		
Category M2	45 to 50 dB (V/m)	35 to 40 dB (V/m)		
Category M3	40 to 45 dB (V/m)	30 to 35 dB (V/m)		
Category M4	<40 dB (V/m)	<30 dB (V/m)		

# 12. HAC (RF Emissions) Test Results

MIF values were not tested by a probe or as specified in the standards but are based on analysis provided by SPEAG for the following User Identifiers and air interfaces.

The data included in this report are for the worst case operating modes. Refer to Appendix D and G for the MIF vales that represent the worst case operation modes.

Air-Interface	Ch. No.	Freq. (MHz)	Results* (dB V/m)	Results plus 0.2dB uncertaninty (dB V/m)	Margin (dB)	M-Rating	Plots Page #
GSM850	128	824.2	34.99	35.19	4.81	M4	1
	190	836.6	35.61	35.81	4.19	M4	2
	251	848.6	36.21	36.41	3.59	M4	3
GSM1900	512	1850.2	29.21	29.41	0.59	M4	4
	661	1880.0	29.54	29.74	0.26	M4	5
	810	1909.8	30.39	30.59	4.41	M3	6
LTE-TDD Band 48 20MHz 16QAM RB 1/0	55340	3560.0	24.03	24.23	5.77	M4	7
	55773	3603.3	24.18	24.38	5.62	M4	8
	56207	3646.7	25.63	25.83	4.17	M4	9
	56640	3690.0	24.81	25.01	4.99	M4	10
NR-TDD	633334	3500.01	18.07	18.27	11.73	M4	11
Band n77	650000	3750.00	21.30	21.50	8.50	M4	12
100MHz DFT-s-OFDM QPSK 30kHz RB 1/1	656000	3840.00	21.26	21.46	8.54	M4	13
	662000	3930.00	20.95	21.15	8.85	M4	14
NR-TDD Band n77 PC2 100MHz DFT-s-OFDM QPSK 30kHz RB 1/1	633334	3500.01	20.47	20.67	9.33	M4	15
	650000	3750.00	23.21	23.41	6.59	M4	16
	656000	3840.00	23.15	23.35	6.65	M4	17
	662000	3930.00	22.80	23.00	7.00	M4	18
W-CDMA & LTE-FDD & NR-FDD & Wi-Fi	Refer to Section 7 Evaluation for Low-power Exemption. RF Emission testing for this device is required only for GSM voice modes, LTE-TDD and NR-TDD. All other applicable air-interfaces are exempt from testing in accordance with C63.19 Clause 4.4 and are rated M4.				M3	N/A	

### Note(s):

<sup>\*:</sup> Measured Audio Interference level in dB (V/m): indirect method (max rms field strength Plus MIF)

Date: 2022-11-10

## 12.1. Worst Case RF Emission Test Plot

Test Laboratory: UL Korea Ltd. Suwon Laboratory

#### **GSM 1900**

Communication System: UID 10021 - DAC, GSM-FDD (TDMA, GMSK); Frequency: 1909.8 MHz; Duty Cycle: 1:8.6896 Phantom section: RF Section DASY5 Configuration:

- Probe: EF3DV3 SN4066; ConvF(1, 1, 1) @ 1909.8 MHz; Calibrated: 2022-07-19
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1668; Calibrated: 2022-04-27
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BB
- Measurement SW: DASY52, Version 52.10 (4); SEMCAD X Version 14.6.14 (7483)

### GSM1900 E-Field measurement/Voice\_ch810/Hearing Aid Compatibility Test

(101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 13.54 V/m; Power Drift = -0.04 dB

Applied MIF = 3.63 dB

RF audio interference level = 30.39 dBV/m

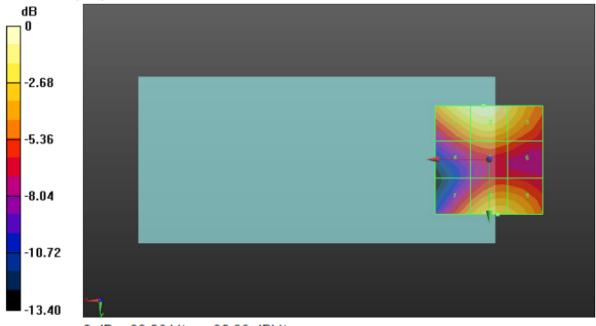
Emission category: M3

#### MIF scaled E-field

Grid 1 <b>M4</b>	Grid 2 M3	Grid 3 M4
29.89 dBV/m	30.39 dBV/m	29.02 dBV/m
Grid 4 <b>M4</b>	Grid 5 M4	Grid 6 M4
25.47 dBV/m	26.2 dBV/m	25.48 dBV/m
Grid 7 <b>M4</b>	Grid 8 <b>M4</b>	Grid 9 <b>M4</b>
26.81 dBV/m	28.52 dBV/m	28.31 dBV/m

### Cursor:

Total = 30.39 dBV/m E Category: M3 Location: 2.5, -25, 7.7 mm



0 dB = 33.06 V/m = 30.39 dBV/m

# **Appendixes**

Refer to separated files for the following appendixes

4790136529-S2 Appendix A: Setup Photo

4790136529-S2 Appendix B: System Validation Plots

4790136529-S2 Appendix C: Test Plots

4790136529-S2 Appendix D: MIF Attestation Letter

4790136529-S2 Appendix E: Probe Certificates

4790136529-S2 Appendix F: Dipole Certificates

4790136529-S2 Appendix G: UID Specifications

**END OF REPORT**